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The semiconductor operations of Hitachi and Mitsubishi Electric were transferred to Renesas Technology Corporation on April 1st 2003. These operations include microcomputer, logic, analog and discrete devices, and memory chips other than DRAMs (flash memory, SRAMs etc.) Accordingly, although Mitsubishi Electric, Mitsubishi Electric Corporation, Mitsubishi Semiconductors, and other Mitsubishi brand names are mentioned in the document, these names have in fact all been changed to Renesas Technology Corp. Thank you for your understanding. Except for our corporate trademark, logo and corporate statement, no changes whatsoever have been made to the contents of the document, and these changes do not constitute any alteration to the contents of the document itself.

Note: Mitsubishi Electric will continue the business operations of high frequency & optical devices and power devices.

Renesas Technology Corp. Customer Support Dept. April 1, 2003



MITSUBISHI LSIs

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

DESCRIPTION

The M5M5W816TP is a family of low voltage 8-Mbit static RAMs organized as 524288-words by 16-bit, fabricated by Mitsubishi's high-performance 0.18µm CMOS technology.

The M5M5W816TP is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

The M5M5W816TP is packaged in a 44pin thin small outline mount device, with the outline of 400mil TSOP TYPE(II). It gives the best solution for a compaction of mounting area as well as flexibility of wiring pattern of printed circuit boards.

FEATURES

- Single 2.7~3.6V power supply
- Small stand-by current: 0.1µA (2.0V, typ.)
- No clocks, No refresh
- Data retention supply voltage =2.0V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by S#, BC1# and BC2#
- Common Data I/O
- Three-state outputs: OR-tie capability
- OE# prevents data contention in the I/O bus
- Process technology: 0.18µm CMOS
- Package: 44pin 400mil TSOP TYPE(II)

| Version, | | | | Stand-by current | | | | | | Activ e |
|-------------|------------------|----------|-------------|------------------|------|------|--------|-------|-------|------------------------|
| Operating | Part name | Power | Access time | * Typ. (@ 3.0V) | | Rati | ngs (m | ax. @ | 3.6V) | current |
| temperature | | Supply | max. | 25°C | 40°C | 25°C | 40°C | 70°C | 85°C | lcc1 *(3.0V typ.) |
| Lucasian | M5M5W816TP -55HI | | 55ns | | 1.0 | 5.0 | | | 40 | 30mA (10MHz) 5mA |
| I-version | M5M5W816TP -70HI | 2.7~3.6V | 70ns | 0.5 | | | 8.0 | 20 | | |
| -40~+85°C | M5M5W816TP -85HI | | 85ns | | | | | | | (1MHz) |

^{*} Typical parameter indicates the value for the center of distribution, and not 100% tested.

PIN CONFIGURATION

| 1 | | 4 A 5 |
|----|--|--|
| 2 | 4 | 3 A 6 |
| 3 | 4 | A 7 |
| 4 | 4 | 11 OE# |
| 5 | 4 | 0 BC2# |
| 6 | _3 | 9 BC1# |
| 7 | 7 | DQ 16 |
| 8 | | DQ 15 |
| 9 | l ÿ | DQ 14 |
| 10 | 3 3 | DQ13 |
| 11 | l š | 4 GND |
| 12 | & | 3 Vcc |
| 13 | <u> </u> | 2 DQ12 |
| 14 | 6 6 | DQ11 |
| 15 | ┨ | DQ10 |
| 16 | | 9 DQ9 |
| 17 | _2 | 8 A 18 |
| 18 | _2 | 27 A 8 |
| 19 | | 6 A9 |
| 20 | | <u>A10</u> A 10 |
| 21 | | 4 A 11 |
| 22 | _2 | 3 A 17 |
| | 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 | 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 |

44Pin 400mil TSOP Outline: 44P3W

| Pin | Function | | | | | |
|------------|-----------------------|--|--|--|--|--|
| A0 ~ A18 | Address input | | | | | |
| DQ1 ~ DQ16 | Data input / output | | | | | |
| S# | Chip select input | | | | | |
| W# | Write control input | | | | | |
| OE# | Output enable input | | | | | |
| BC1# | Lower Byte (DQ1 ~ 8) | | | | | |
| BC2# | Upper Byte (DQ9 ~ 16) | | | | | |
| Vcc | Power supply | | | | | |
| GND | Ground supply | | | | | |

MITSUBISHI LSIs

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

FUNCTION

The M5M5W816TP is organized as 524288-words by 16-bit. These devices operate on a single +2.7~3.6V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

The operation mode are determined by a combination of the device control inputs BC1#, BC2#, S#, W# and OE#. Each mode is summarized in the function table.

A write operation is executed whenever the low level W# overlaps with the low level BC1# and/or BC2# and the low level S#. The address(A0~A18) must be set up before the write cycle and must be stable during the entire cycle.

A read operation is executed by setting W# at a high level and OE# at a low level while BC1# and/or BC2# and S# are in an active state(S#=L).

When setting BC1# at the high level and other pins are in an active stage, upper-byte are in a selectable mode in which both reading and writing are enabled, and lower-byte are in a non-selectable mode. And when setting BC2# at a high level and other pins are in an active stage, lower-byte are in a selectable mode and upper-byte are in a non-selectable mode.

When setting BC1# and BC2# at a high level or S# at a high level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by BC1#, BC2# and S#.

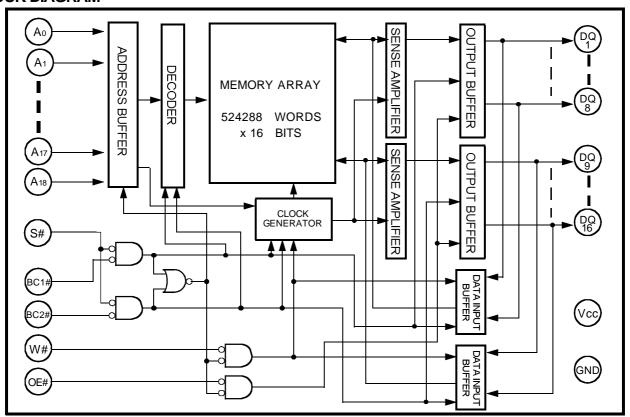
The power supply current is reduced as low as $0.1\mu A(25^{\circ}C$, typical), and the memory data can be held at +2.0V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

| S | # | BC1# | BC2# | W# | OE# | Mode | DQ1~8 | DQ9~16 | Icc |
|---|---|------|------|----|-----|---------------|--------|--------|---------|
| H | 1 | Х | Χ | Х | Χ | Non selection | High-Z | High-Z | Standby |
|) | > | Η | Н | Х | Χ | Non selection | High-Z | High-Z | Standby |
| | | L | Η | L | Χ | Write | Din | High-Z | Activ e |
| | | L | Η | Η | L | Read | Dout | High-Z | Activ e |
| L | 1 | L | Ι | Ι | Η | | High-Z | High-Z | Activ e |
| L | - | Н | L | L | Χ | Write | High-Z | Din | Activ e |
| | | Н | L | Η | L | Read | High-Z | Dout | Activ e |
| | _ | Н | L | Н | Η | | High-Z | High-Z | Activ e |
| | | L | L | L | Χ | Write | Din | Din | Activ e |
| | | L | L | Η | L | Read | Dout | Dout | Activ e |
| L | _ | L | L | Н | Н | | High-Z | High-Z | Activ e |

(note) "H" and "L" in this table mean VIH or VIL, respectively . "X" in this table should be "H" or "L".

BLOCK DIAGRAM



MITSUBISHI LSIs

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Conditions | Ratings | |
|--------|-----------------------|---------------------|-------------------------------|----|
| Vcc | Supply voltage | With respect to GND | -0.3* ~ +4.6 | |
| Vı | Input voltage | With respect to GND | -0.3* ~ Vcc + 0.3 (max. 4.6V) | V |
| Vo | Output voltage | With respect to GND | 0 ~ Vcc | |
| Pd | Power dissipation | Ta= 25°C | 700 | mW |
| Ta | Operating temperature | | - 40 ~ +85 | °C |
| Tstg | Storage temperature | | - 65 ~ +150 | °C |

^{* -3.0}V in case of AC (Pulse width \leq 30ns)

DC ELECTRICAL CHARACTERISTICS

(Vcc=2.7 ~ 3.6V, unless otherwise noted)

| O male al | | | | | | | |
|-----------|---|--|----------|--------|-----|----------|-------|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Units |
| VIH | High-level input voltage | | | 2.2 | | Vcc+0.2V | |
| VIL | Low-level input voltage | Iон= - 0.5mA | | -0.2 * | | 0.6 | |
| Vон | High-level output voltage | | | 2.4 | | | V |
| Vol | Low-level output voltage | loL=2mA | | | | 0.4 | |
| - Ii | Input leakage current | rrent V _I =0 ~ Vcc | | | | ±1 | μA |
| lo | Output leakage current BC1# and BC2#=VIH or S#=VIH or OE#=VIH, VI/O=0 ~ Vcc | | | | ±1 | μΛ | |
| lcc1 | Active supply current | PC1# and BC2# ≤ 0.2V, S# ≤ 0.2V other inputs ≤ 0.2V or ≥ Vcc-0.2V | f= 10MHz | - | 30 | 50 | |
| ICCT | (AC,MOS level) | Output - open (duty 100%) | f= 1MHz | - | 5 | 15 | |
| | Active supply current | BC1# and BC2#=VIL , S#=VIL other pins =VIH or VIL | f= 10MHz | - | 30 | 50 | mΑ |
| Icc2 | (AC,TTL level) | Output - open (duty 100%) | f= 1MHz | - | 5 | 15 | |
| | | (1) S# ≥ Vcc - 0.2V, | ~ +25°C | - | 0.5 | 5 | |
| | Stand by supply current | other inputs = 0 ~ Vcc | ~ +40°C | - | 1.0 | 8 | |
| lcc3 | (AC,MOS level) | (2) BC1# and BC2# ≥ Vcc - 0.2V S# < 0.2V | ~ +70°C | - | - | 20 | μA |
| | | other inputs = 0 ~ Vcc | ~ +85°C | - | - | 40 | |
| lcc4 | Stand by supply current (AC,TTL level) | BC1# and BC2# = VIH or S# = VIH Other inputs= 0 ~ Vcc | | - | - | 2 | mA |

Note 1: Direction for current flowing into IC is indicated as positive (no mark).

CAPACITANCE

(Vcc=2.7 ~ 3.6V, unless otherwise noted)

| Symbol | Doromotor | Conditions | Limits | | | 11.24 |
|------------------|--------------------|----------------------------|--------|-----|-------|-------|
| Symbol Parameter | Conditions | Min | Тур | Max | Units | |
| Сі | Input capacitance | Vi=GND, Vi=25mVrms, f=1MHz | | | 10 | pF |
| Со | Output capacitance | Vo=GND,Vo=25mVrms, f=1MHz | | | 10 | рг |



^{* -1.0}V in case of AC (Pulse width \leq 30ns)

Note 2: Typical parameter indicates the value for the center of distribution at 3.0V, and not 100% tested.

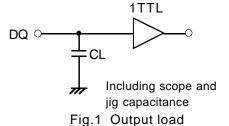
MITSUBISHI LSIs

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

AC ELECTRICAL CHARACTERISTICS (Vcc=2.7 ~ 3.6V, unless otherwise noted)

(1) TEST CONDITIONS

| Supply voltage | 2.7~3.6V |
|-------------------------------|--|
| Input pulse | V _{IH} =2.4V, V _{IL} =0.4V |
| Input rise time and fall time | 5ns |
| Reference level | VoH=VoL=1.50V Transition is measured ±200mV from steady state voltage.(for ten,tdis) |
| Output loads | Fig.1,CL=30pF CL=5pF (for ten.tdis) |



(2) READ CYCLE

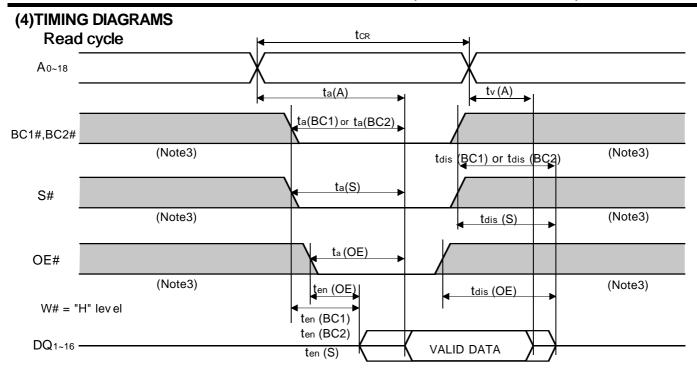
| | | | | Lin | nits | | | |
|------------|--|-----|------|-----|------|-----|-----|-------|
| Symbol | Parameter | 55 | 55HI | | 70HI | | HI | Units |
| Cymbol | r didinotor | Min | Max | Min | Max | Min | Max | |
| tcr | Read cycle time | 55 | | 70 | | 85 | | ns |
| ta(A) | Address access time | | 55 | | 70 | | 85 | ns |
| ta(S) | Chip select 1 access time | | 55 | | 70 | | 85 | ns |
| ta(BC1) | Byte control 1 access time | | 55 | | 70 | | 85 | ns |
| ta(BC2) | Byte control 2 access time | | 55 | | 70 | | 85 | ns |
| ta(OE) | Output enable access time | | 30 | | 35 | | 45 | ns |
| tdis(S) | Output disable time after S# high | | 20 | | 25 | | 30 | ns |
| tdis(BC1) | Output disable time after BC1# high | | 20 | | 25 | | 30 | ns |
| tdis(BC2) | Output disable time after BC2# high | | 20 | | 25 | | 30 | ns |
| tdis(OE) | Output disable time after OE# high | | 20 | | 25 | | 30 | ns |
| ten(S) | Output enable time after S# low | 10 | | 10 | | 10 | | ns |
| ten(BC1,2) | Output enable time after BC1#,BC2# low | 5 | | 5 | | 5 | | ns |
| ten(OE) | Output enable time after OE# low | 5 | | 5 | | 5 | | ns |
| t∨(A) | Data valid time after address | 10 | | 10 | | 10 | | ns |

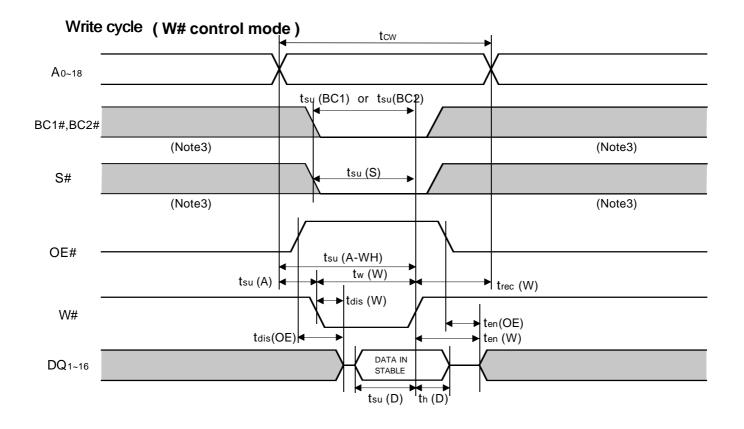
(3) WRITE CYCLE

| Symbol | Parameter | 55 | 55HI | | 70HI | | 85HI | |
|--------------------|---------------------------------------|-----|------|-----|------|-----|------|----|
| - 9 | | Min | Max | Min | Max | Min | Max | |
| tcw | Write cycle time | 55 | | 70 | | 85 | | ns |
| t _w (W) | Write pulse width | 45 | | 55 | | 60 | | ns |
| tsu(A) | Address setup time | 0 | | 0 | | 0 | | ns |
| tsu(A-WH) | Address setup time with respect to W# | 50 | | 65 | | 70 | | ns |
| tsu(BC1) | Byte control 1 setup time | 50 | | 65 | | 70 | | ns |
| tsu(BC2) | Byte control 2 setup time | 50 | | 65 | | 70 | | ns |
| tsu(S) | Chip select setup time | 50 | | 65 | | 70 | | ns |
| tsu(D) | Data setup time | 30 | | 35 | | 45 | | ns |
| th(D) | Data hold time | 0 | | 0 | | 0 | | ns |
| trec(W) | Write recovery time | 0 | | 0 | | 0 | | ns |
| tdis(W) | Output disable time from W# low | | 20 | | 25 | | 30 | ns |
| tdis(OE) | Output disable time from OE# high | | 20 | | 25 | | 30 | ns |
| ten(W) | Output enable time from W# high | 5 | | 5 | | 5 | | ns |
| ten(OE) | Output enable time from OE# low | 5 | | 5 | | 5 | | ns |

MITSUBISHI LSIs

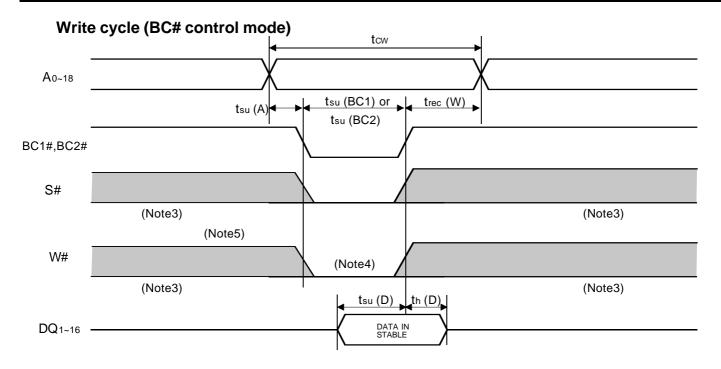
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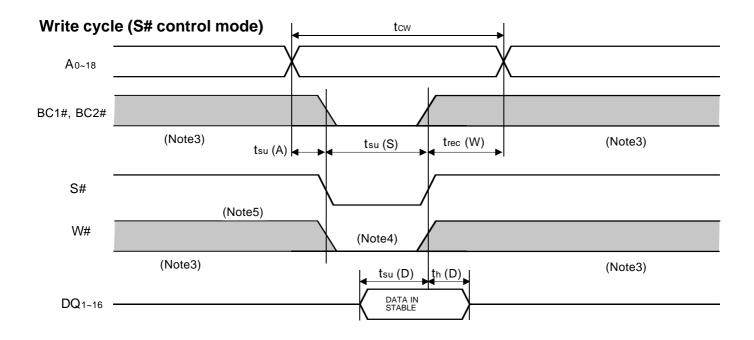
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- Note 3: Hatching indicates the state is "don't care".
- Note 4: A Write occurs during S# low overlaps BC1# and/or BC2# low and W# low.
- Note 5: When the falling edge of W# is simultaneously or prior to the falling edge of BC1# and/or BC2# or the falling edge of S#, the outputs are maintained in the high impedance state.
- Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.

MITSUBISHI LSIs

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM



MITSUBISHI LSIs

8388608-BIT (524288-WORD BY 16-BIT) CMOS STATIC RAM

POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS

| Symbol | Parameter | Test conditions | Test conditions | | | Max | Units |
|----------|---------------------------------|-------------------------------------|-----------------|---------|---------|-----|-------|
| Vcc (PD) | Power down supply voltage | | 2.0 | | | V | |
| VI (BC) | Byte control input BC1# & BC2# | 2.2V <u><</u> Vcc(PD) | | 2.2 | | | V |
| \$1 (BB) | byto control input bo in a bozi | 2.0V ≤ Vcc(PD) ≤ 2.2V | | | Vcc(PD) | | V |
| V(1/0) | 01: 1 :: 10" | 2.2V ≤ Vcc(PD) | 2.2 | | | ., | |
| VI (S) | Chip select input S# | 2.0V ≤ Vcc(PD) ≤ 2.2V | | Vcc(PD) | | V | |
| | | Vcc=2.0V | ~ +25°C | - | 0.1 | 1.5 | |
| Icc (PD) | Power down | ent (2) BC1# and BC2# ≥ Vcc - 0.2V | ~ +40°C | - | 0.2 | 3 | μΑ |
| | supply current | | ~ +70°C | - | - | 15 | |
| | | S# ≤ 0.2V other inputs = 0 ~ Vcc | ~ +85°C | - | - | 30 | |

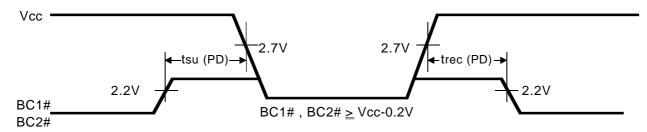
Note 7: Typical parameter of Icc(PD) indicates the value for the center of distribution at 2.0V, and not 100% tested.

(2) TIMING REQUIREMENTS

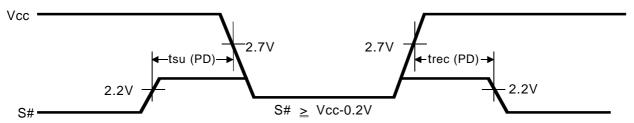
| Symbol | _ | - | | 11. 14 | | |
|-----------|--------------------------|-----------------|-----|--------|-----|-------|
| | Parameter | Test conditions | Min | Тур | Max | Units |
| tsu (PD) | Power down set up time | | 0 | | | ns |
| trec (PD) | Power down recovery time | | 5 | | | ms |

(3) TIMING DIAGRAM

BC# control mode On the BC# control mode, the level of S# must be fixed at S# \geq Vcc-0.2V or S# \leq 0.2V.



S# control mode



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